APPLICATION (PTO-1449)    Comparison of Com	INF	ORMATION CITATIO	DISCLOSURE	ATTY. DOCKE 4459-090A	ATTY. DOCKET NO. 4459-090A		U.S. PATENT APPLICATION NO.			
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U.S. PATENT DOCUMENTS	(PTO 1440)			_		GROUP				
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NAME			U.S. PATEN	DOCUMENTS						
6,020,633   02-2000   Erickson		PATENT NO.	DATE	NAME	CLASS	SUBCLASS				
6,040,530   03-2000   Wharton et al.	4.m. H	5,840,417	11-1998	Bolger						
6,121,554   09-2000   Kamikawa		6,020,633	02-2000	Erickson						
6,326,555   12-2001   McCormack et al.		6,040,530	03-2000	Wharton et al.						
6,400,174		6,121,554	09-2000	Kamikawa						
6,483,329   11-2002   Cram		6,326,555	12-2001 N	IcCormack et al.						
6,535,005   03-2003   Field		6,400,174	06-2002	Akram et al.						
5,440,239		6,483,329	11-2002	Cram						
5,801,536   09-1998   Brambilla et al.		6,535,005	03-2003	Field	1-1-					
6,075,710 06-2000 Lau 6,288,559 09-2001 Bernier et al. 6,564,986 05-2003 Hsieh  FOREIGN PATENT DOCUMENTS  EXAMINER'S INITIALS PATENT NO. DATE COUNTRY CLASS SUBCLASS Translation Yes No  OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)		5,440,239	08-1995	Zappella et al.						
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